

Notice of References Cited	Application/Control No. 09/661,806	Applicant(s)/Patent Under Reexamination HASEGAWA ET AL.	
	Examiner Sunray Chang	Art Unit 2121	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,151,026 A	11-2000	Iwade et al.	345/420
	B	US-5,880,736 A	03-1999	Peercy et al.	345/426
	C	US-			
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	J	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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